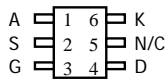
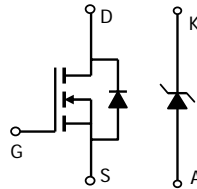



AO6702
**N-Channel Enhancement Mode Field Effect Transistor
with Schottky Diode**
General Description

The AO6702 uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. A Schottky diode is provided to facilitate the implementation of a bidirectional blocking switch, or for DC-DC conversion applications. *Standard Product AO6702 is Pb-free (meets ROHS & Sony 259 specifications). AO6702L is a Green Product ordering option. AO6702 and AO6702L are electrically identical.*

Features

$V_{DS} (V) = 20V$
 $I_D = 3.8A (V_{GS} = 4.5V)$
 $R_{DS(ON)} < 50m\Omega (V_{GS} = 4.5V)$
 $R_{DS(ON)} < 65m\Omega (V_{GS} = 2.5V)$
 $R_{DS(ON)} < 95m\Omega (V_{GS} = 1.8V)$
SCHOTTKY
 $V_{DS} (V) = 20V, I_F = 1A, V_F < 0.5V @ 0.5A$


TSOP6

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | MOSFET | Schottky | Units |
|---|----------------|------------------|------------|------------|
| Drain-Source Voltage | V_{DS} | 20 | | V |
| Gate-Source Voltage | V_{GS} | ± 8 | | V |
| Continuous Drain Current ^A | I_D | $T_A=25^\circ C$ | 3.8 | A |
| | | $T_A=70^\circ C$ | 3 | |
| Pulsed Drain Current ^B | I_{DM} | 10 | | |
| Schottky reverse voltage | V_{KA} | | 20 | V |
| Continuous Forward Current ^A | I_F | $T_A=25^\circ C$ | 2 | A |
| | | $T_A=70^\circ C$ | 1 | |
| Pulsed Forward Current ^B | I_{FM} | | 10 | |
| Power Dissipation | P_D | $T_A=25^\circ C$ | 1.15 | W |
| | | $T_A=70^\circ C$ | 0.7 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | -55 to 150 | $^\circ C$ |

| Parameter: Thermal Characteristics MOSFET | | Symbol | Typ | Max | Units |
|---|--------------|-----------------|-------|-----|--------------|
| Maximum Junction-to-Ambient ^A | $t \leq 10s$ | $R_{\theta JA}$ | 80.3 | 110 | $^\circ C/W$ |
| Maximum Junction-to-Ambient ^A | Steady-State | | 117 | 150 | |
| Maximum Junction-to-Lead ^C | Steady-State | $R_{\theta JL}$ | 43 | 80 | |
| Thermal Characteristics Schottky | | | | | |
| Maximum Junction-to-Ambient ^A | $t \leq 10s$ | $R_{\theta JA}$ | 109.4 | 135 | $^\circ C/W$ |
| Maximum Junction-to-Ambient ^A | Steady-State | | 136.5 | 175 | |
| Maximum Junction-to-Lead ^C | Steady-State | $R_{\theta JL}$ | 58.5 | 80 | |

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|--|-------------------------------------|------------|----------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | 20 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =16V, V _{GS} =0V T _J =55°C | | | 1 5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±8V | | | 100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250μA | 0.4 | 0.6 | 1 | V |
| I _{D(ON)} | On state drain current | V _{GS} =4.5V, V _{DS} =5V | 10 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =4.5V, I _D =3.8A T _J =125°C | | 41.6 63 | 50 80 | mΩ |
| | | V _{GS} =2.5V, I _D =3.3A | | 54 | 65 | |
| | | V _{GS} =1.8V, I _D =2.8A | | 74 | 95 | mΩ |
| | | | | | | |
| g _{FS} | Forward Transconductance | V _{DS} =5V, I _D =3.8A | | 10.5 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.8 | 1 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | 1.8 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =10V, f=1MHz | | 449 | | pF |
| C _{oss} | Output Capacitance | | | 74 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 51.6 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | 4.9 | | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _g | Total Gate Charge | V _{GS} =4.5V, V _{DS} =10V, I _D =3.8A | | 5.9 | | nC |
| Q _{gs} | Gate Source Charge | | | 0.36 | | nC |
| Q _{gd} | Gate Drain Charge | | | 1.3 | | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =5V, V _{DS} =10V, R _L =2.6Ω, R _{GEN} =0Ω | | 4.5 | | ns |
| t _r | Turn-On Rise Time | | | 6 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 32.7 | | ns |
| t _f | Turn-Off Fall Time | | | 7.1 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | | I _F =3.8A, di/dt=100A/μs | | 13 | |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =3.8A, di/dt=100A/μs | | 3.3 | | nC |
| SCHOTTKY PARAMETERS | | | | | | |
| V _F | Forward Voltage Drop | I _F =0.5A | | 0.39 | 0.5 | V |
| I _{rm} | Maximum reverse leakage current | V _R =16V | | | 0.02 | mA |
| | | V _R =16V, T _J =125°C | | | 20 | |
| C _T | Junction Capacitance | V _R =10V | | 34 | | pF |
| t _{rr} | Schottky Reverse Recovery Time | I _F =1A, di/dt=100A/μs | | 5.2 | 10 | ns |
| Q _{rr} | Schottky Reverse Recovery Charge | I _F =1A, di/dt=100A/μs | | 0.8 | | nC |

A: The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using 80μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

Rev3: August 2005

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

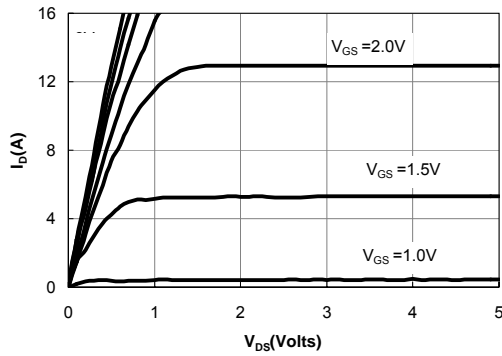


Figure 1: On-Regions Characteristics

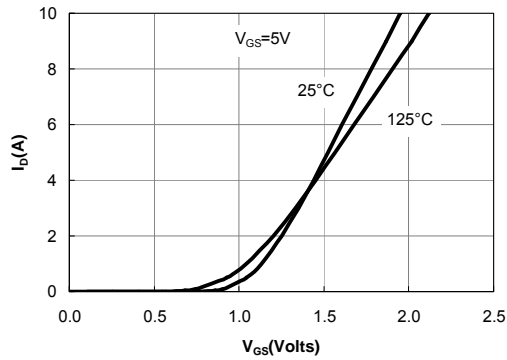


Figure 2: Transfer Characteristics

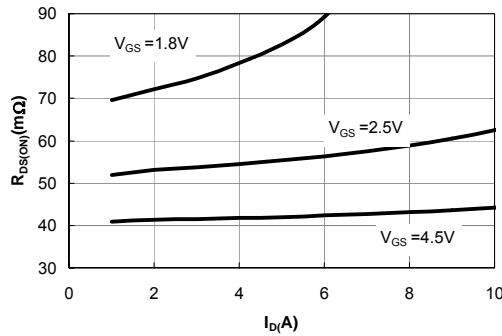


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

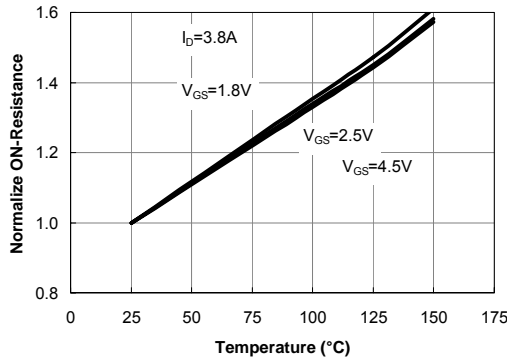


Figure 4: On-Resistance vs. Junction Temperature

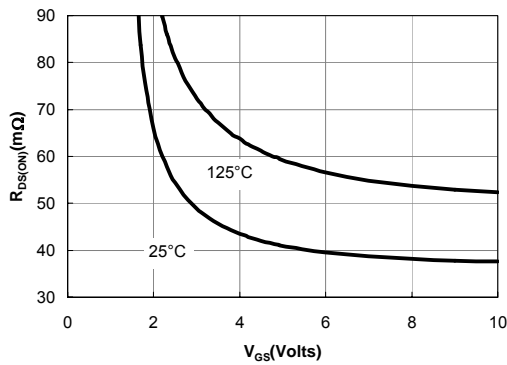


Figure 5: On-Resistance vs. Gate-Source Voltage

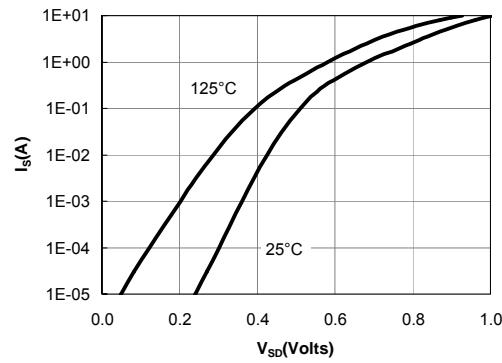


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

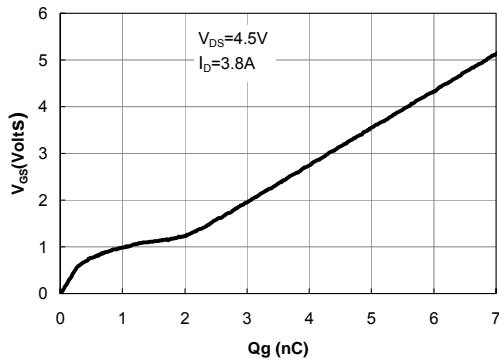


Figure 7: Gate-Charge Characteristics

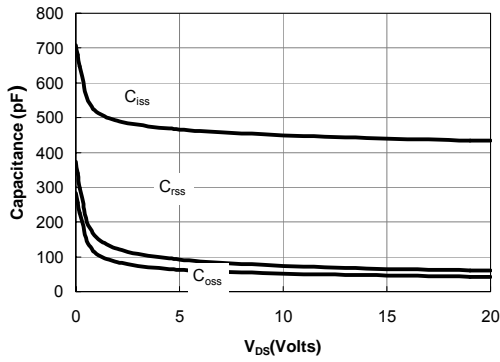


Figure 8: Capacitance Characteristics

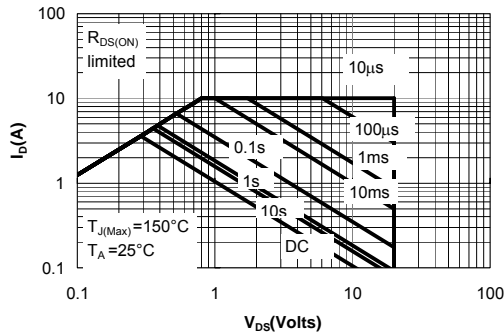


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

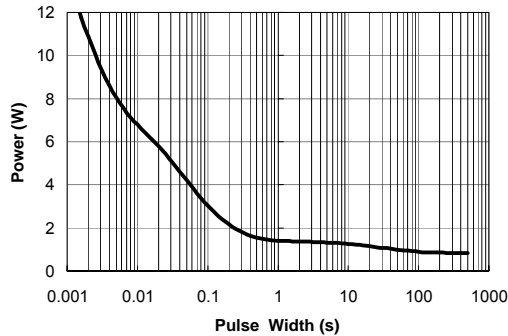


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

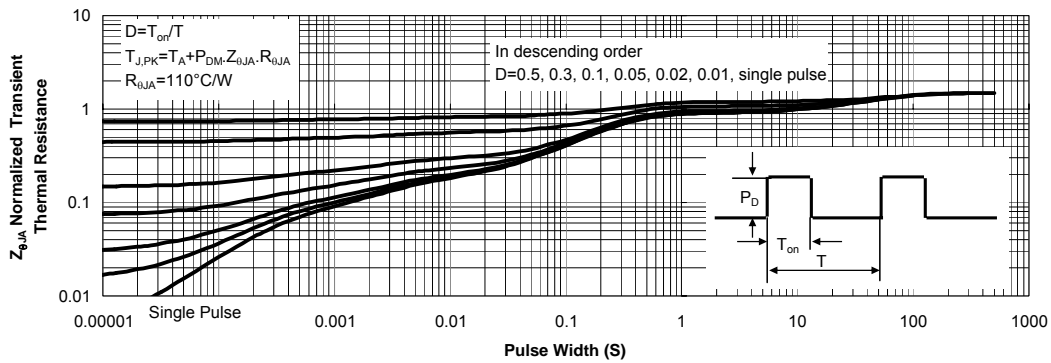


Figure 11: Normalized Maximum Transient Thermal Impedance

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: SCHOTTKY

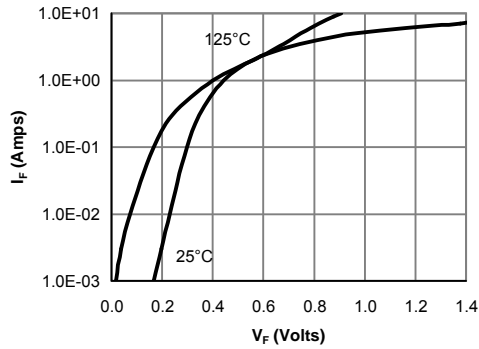


Figure 12: Schottky Forward Characteristics

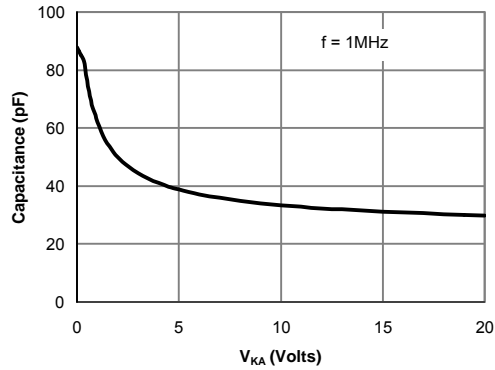


Figure 13: Schottky Capacitance Characteristics

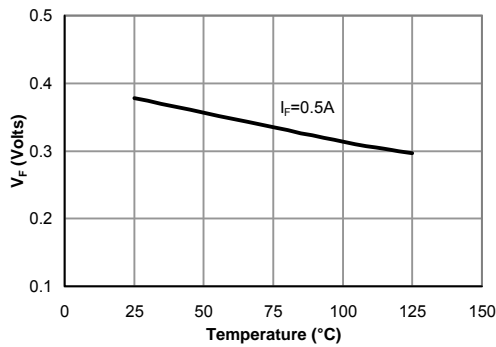


Figure 14: Schottky Forward Drop vs. Junction Temperature

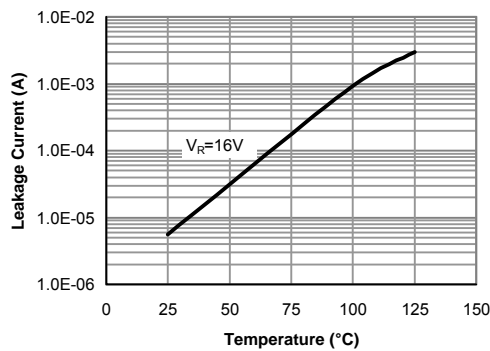


Figure 15: Schottky Leakage current vs. Junction Temperature

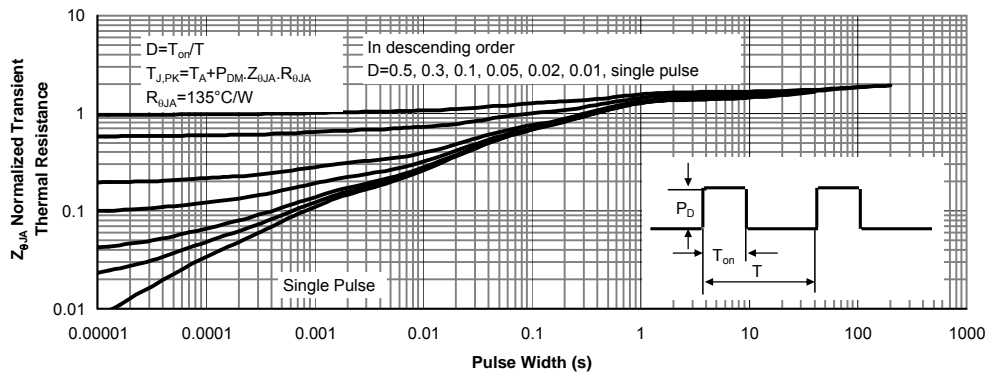


Figure 15: Schottky Normalized Maximum Transient Thermal Impedance